Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,386	HAYASHI, KENJI	
Examiner	Art Unit	
Lana N. Le	2685	

SEARCHED					
Class	Subclass	Date		Examiner	
455	73	2/5/2006		L.L.	
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INTERFERENCE SEARCHED						
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East-subclasses -keywords	2/5/2006	L.L.	
consulted with: Vo, Nguyen			